TOSHIBA CMOS DIGITAL INTEGRATED CIRCUIT SILICON MONOLITHIC

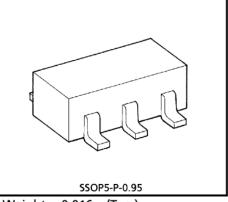
TC4S71F

2 INPUT OR GATE

The TC4S71F is 2-input positive logic OR gates. Gate output with inverter buffer improve the inputoutput characteristics and even if the load capacitance increases, it can be stopped the change of propagation time.

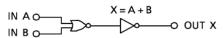
MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT
DC Supply Voltage	V_{DD}	$V_{SS} - 0.5 \sim V_{SS} + 20$	V
Input Voltage	VIN	$V_{SS} = 0.5 \sim V_{DD} + 0.5$	V
Output Voltage	Vout	$V_{SS} - 0.5 \sim V_{DD} + 0.5$	V
DC Input Current	IN	± 10	mA
Power Dissipation	PD	200	mW
Operating Temperature Range	T _{opr}	- 40~85	°C
Storage Temperature Range	T _{stg}	- 65~150	°C
Lead Temperature (10s)	TL	260	°C

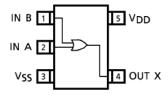


Weight: 0.016g (Typ.)

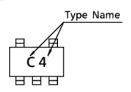
LOGIC DIAGRAM



PIN CONFIGURATION (TOP VIEW)



MARKING



2008-06-03

RECOMMENDED OPERATING CONDITIONS $(V_{SS} = 0V)$

CHARACTERISTIC	SYMBOL		MIN.	TYP.	MAX.	UNIT
DC Supply Voltage	V_{DD}	_	3	_	18	V
Input Voltage	VIN	1	0	_	V_{DD}	V

STATIC ELECTRICAL CHARACTERISTICS $(V_{SS} = 0V)$

CHARACTERISTIC	SYM-	TEST CONDITION	VDD	– 40°C		25°C			85°C		UNIT
BOL	TEST CONDITION	V _{DD}	MIN.	MAX.	MIN.	TYP.	MAX.	MIN.	MAX.	OINIT	
High-Level		l _{OUT} <1μΑ	5	4.95		4.95		I	4.95	l .	
Output Voltage	Vон	$V_{IN} = V_{SS}$, V_{DD}	10	9.95		9.95		ı	9.95	l .	
		11N 1337 100	15	14.95		14.95			14.95		l v l
Low-Level Output Voltage	 l _{OUT} <1μΑ	5	-	0.05	—	0.00	I	—	0.05	-	
	VOL	$V_{IN} = V_{SS}$	10	-	0.05	—	0.00		—	0.05	
- Catput Fortage			15	_	0.05	_	0.00		_	0.05	
		V _{OH} = 4.6V	5	- 0.61		- 0.51	- 1.0	I	- 0.42	l .	
Output High	ІОН	V _{OH} = 2.5V	5	- 2.5		- 2.1	- 4.0	I	- 1.7	—	
Current	l'OH	V _{OH} = 9.5V	10	- 1.5		- 1.3		I	- 1.1		
		$V_{IN} = V_{DD}$, V_{SS}	15	- 4.0		- 3.4	- 9.0	_	- 2.8	_	
		V _{OL} = 0.4V	5	0.61		0.51			0.42		mΑ
Output Low	ļ.,.	$V_{OL} = 0.5V$	10	1.5	_	1.3	3.2	—	1.1	_	
Current	lOL	V _{OL} = 1.5V	15	4.0	_	3.4	12.0	—	2.8	_	
		$V_{IN} = V_{SS}$									
		V _{OUT} = 4.5V	5	3.5		3.5	2.75	_	3.5	_	
Innut High Valtons	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	V _{OUT} = 9.0V	10	7.0	_	7.0	5.5	—	7.0	_	
Input High Voltage	VIH	V _{OUT} = 13.5V	15	11.0	_	11.0	8.25	—	11.0	_	
		l _{OUT} <1μA]								.,
		V _{OUT} = 4.5V, 0.5V	5	_	1.5	_	2.25	1.5	_	1.5	V
Input Low Voltage V _I [V _{OUT} = 9.0V, 1.0V	10	—	3.0	—	4.5	3.0	—	3.0	
	VIL	V _{OUT} = 13.5V, 1.5V	15	—	4.0	—	6.75	4.0	—	4.0	
		l _{OUT} <1μA	1								
Input H Level	ΊΗ	V _{IH} = 18V	18	_	0.1	-	10-5		_	1.0	
Current L Level	ΊL	V _{IL} = 0V	18	_	- 0.1	_	- 10 ^{- 5}	- 0.1	—	- 1.0	μ A
Quiescent		V _{IN} = V _{SS} , V _{DD}	5	_	0.25	_	0.001		_	7.5	
Device Current	lDD	* NIM = ASS' ADD	10	—	0.5	_	0.001	0.5	—	15	μ A
Device Current		"	15	_	1.0	_	0.002	1.0	—	30	

^{*} All valid input combinations.

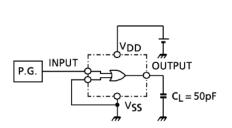
DYNAMIC ELECTRICAL CHARACTERISTICS (Ta = 25°C, $V_{SS} = 0V$, $C_L = 50pF$)

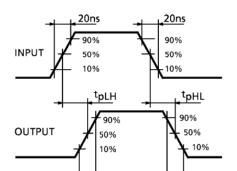
CHARACTERISTIC	SYMBOL	TEST CONDITION	V _{DD} (V)	MIN.	TYP.	MAX.	UNIT	
Output Transition Time			5	_	70	200		
Output Transition Time	tTLH	_	10	_	35	100		
(Low to High)			15	_	30	80		
Output Transition Time (High to Low)			5	_	70	200	ns	
	^t THL	_	10	_	35	100		
			15	_	30	80		
	t _{pLH}		5	_	65	200		
Propagation Delay Time		_	10	_	30	100		
			15	_	25	80	200	
	t _{pHL}		5	_	65	200	ns	
Propagation Delay Time		_	10	_	30	100		
			15	_	25	80		
Input Capacitance	CIN	_	_	5	7.5	pF		

WAVEFORM

CIRCUIT AND WAVEFORM FOR MEASUREMENT OF DYNAMIC CHARACTERISTICS

TEST CIRCUIT





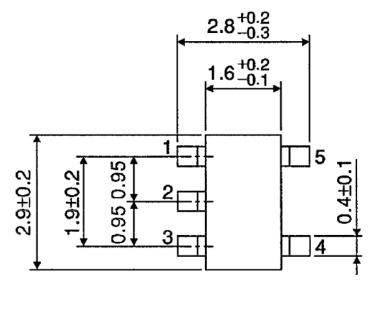
^tTLH

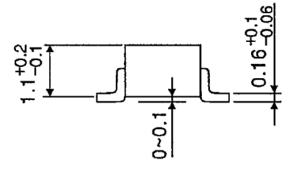
tTHL

PACKAGE DIMENSIONS

SSOP5-P-0.95

Unit: mm





Weight: 0.016g (Typ.)

RESTRICTIONS ON PRODUCT USE

20070701-EN GENERAL

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